**IGBT MODULE** Spec.No.IGBT-SP-10024 R7 P 1

### MBN3600E17F

Silicon N-channel IGBT 1700V F version

#### **FEATURES**

\* Soft switching behavior & low conduction loss:

Soft low-injection punch-through with

Advanced trench HiGT\* (\*High conductivity IGBT)

\* Low driving power:

Low input capacitance advanced trench gate.

\* Low noise recovery: Ultra soft fast recovery diode.

#### **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub>=25°C)

| Item                      |                   | Symbol             | Unit             | MBN3600E17F        |
|---------------------------|-------------------|--------------------|------------------|--------------------|
| Collector Emitter Voltage |                   | V <sub>CES</sub>   | V                | 1,700              |
| Gate Emitter Voltage      |                   | V <sub>GES</sub>   | V                | ±20                |
| Collector Current         | DC                | Ic                 | ^                | 3,600              |
|                           | 1ms               | I <sub>CRM</sub>   | <u>—</u> А       | 7,200              |
| Forward Current           | DC                | l <sub>F</sub>     | A                | 3,600              |
|                           | 1ms               | I <sub>FRM</sub>   |                  | 7,200              |
| Junction Temperature      | •                 | T <sub>vj op</sub> | °C               | -50 ~ +150         |
| Storage Temperature       |                   | T <sub>stg</sub>   | °C               | -55 ~ +125         |
| Isolation Voltage         |                   | V <sub>ISO</sub>   | V <sub>RMS</sub> | 4,000(AC 1 minute) |
| Screw Torque              | Terminals (M4/M8) | -                  | N⋅m              | 2/15 (1)           |
|                           | Mounting (M6)     | -                  | 111-111          | 6 (2)              |

Notes: (1) Recommended Value 1.8±0.2/15+0\_3N⋅m (2) Recommended Value 5.5±0.5N⋅m

#### **ELECTRICAL CHARACTERISTICS**

| Item                                 | Symbol               | Unit | Min. | Тур.  | Max.   | Test Conditions  |
|--------------------------------------|----------------------|------|------|-------|--------|--|
| Callantar Emittar Cut Off Current    | I <sub>CES</sub>     | mA   | -    | -     | 10     | V <sub>CE</sub> =1,700V, V <sub>GE</sub> =0V, T <sub>vi</sub> =25°C        |
| Collector Emitter Cut-Off Current    |                      |      | -    | 35    | 150    | V <sub>CE</sub> =1,700V, V <sub>GE</sub> =0V, T <sub>vi</sub> =150°C       |
| Gate Emitter Leakage Current         | I <sub>GES</sub>     | nA   | -500 | -     | +500   | $V_{GE}=\pm20V$ , $V_{CE}=0V$ , $T_{vj}=25$ °C                             |
| Collector Emitter Saturation Voltage | V <sub>CEsat</sub>   | V    | -    | 2.4   | 2.8    | I <sub>C</sub> =3,600A, V <sub>GE</sub> =15V, T <sub>vi</sub> =150°C       |
| Gate Emitter Threshold Voltage       | $V_{GE(th)}$         | V    | 4.1  | 5.5   | 7.1    | V <sub>CE</sub> =10V, I <sub>C</sub> =360mA, T <sub>Vj</sub> =25°C         |
| Input Capacitance                    | Cies                 | nF   | 1    | 177   | -      | V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, T <sub>vj</sub> =25°C |
| Internal Gate Resistance             | R <sub>G(int)</sub>  | Ω    | •    | 1.3   | -      | V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, T <sub>vj</sub> =25°C |
| Turn On Delay Time                   | t <sub>d(on)</sub>   | μs   | •    | 1.05  | 2.0    | V <sub>CC</sub> =900V, I <sub>C</sub> =3,600A                              |
| Rise Time                            | tr                   |      | -    | 0.35  | 0.8    | L <sub>S</sub> =55nH   |
| Turn Off Delay Time                  | t <sub>d(off)</sub>  |      | -    | 1.7   | 3.4    | $R_G(\text{on/off})=3.3/3.3\Omega$ (3)                                     |
| Fall Time                            | t <sub>f</sub>       |      | -    | 1.6   | 3.2    | $V_{GE}=\pm 15V, T_{vj}=150^{\circ}C$                                      |
| Peak Forward Voltage Drop            | V <sub>F</sub>       | V    | -    | 2.25  | 2.7    | I <sub>F</sub> =3,600A, V <sub>GE</sub> =0V, T <sub>vj</sub> =150°C        |
| Reverse Recovery Time                | t <sub>rr</sub>      | μS   | -    | 0.8   | 1.6    | V <sub>CC</sub> =900V, I <sub>F</sub> =3,600A, L <sub>S</sub> =55nH        |
|                                      | **                   |      |      |       |        | T <sub>vj</sub> =150°C   |
| Turn On Loss                         | Eon                  | J/P  | -    | 1.4   | -      | V <sub>CC</sub> =900V, I <sub>C</sub> =3,600A, L <sub>S</sub> =55nH        |
| Turn Off Loss                        | E <sub>off</sub>     | J/P  | -    | 3.0   | -      | $R_G(\text{on/off}) = 3.3/3.3\Omega$ (3)                                   |
| Reverse Recovery Loss                | Err                  | J/P  | -    | 1.15  | -      | $V_{GE}=\pm 15V, T_{vj}=150^{\circ}C$                                      |
| Short Circuit Pulse Width            | t <sub>sc</sub>      | μS   | 10   | -     |        | V <sub>CC</sub> =1,100V,Ls=55nH  |
| Short Circuit i dise width           | LSC                  |      |      |       | _      | $R_G(\text{on/off})=3.3/15\Omega, V_{GE}=\pm 15V, T_{vj}=150^{\circ}C$     |
| Stray inductance module              | L <sub>SCE</sub>     | nΗ   | -    | 8     | -      |  |
| Thermal Impedance IGBT               | R <sub>th(j-c)</sub> | K/W  | -    | -     | 0.0072 | Junction to case   |
| FVVD                                 | R <sub>th(j-c)</sub> |      | -    | -     | 0.011  |  |
| Contact Thermal Impedance            | R <sub>th(c-f)</sub> | K/W  | -    | 0.005 | -      | Case to fin  |

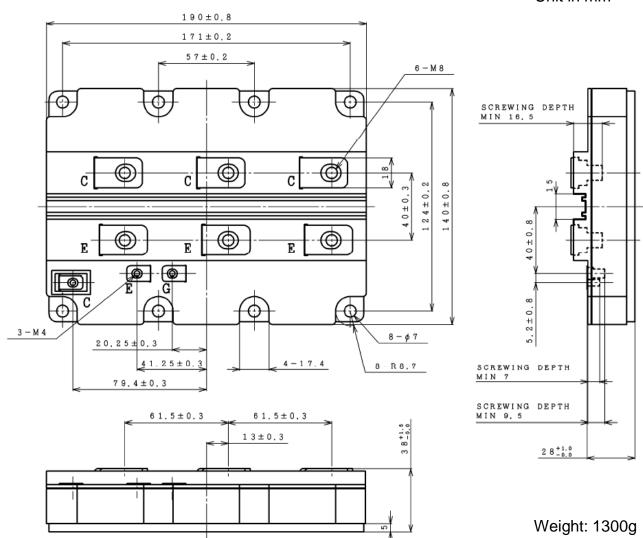
Notes: (3) R<sub>G</sub> value is a test condition value for evaluation, not recommended value. Please, determine the suitable R<sub>G</sub> value by measuring switching behaviors.

- \* For improvement, specifications are subject to change without notice.
- \* For actual application, please confirm this spec sheet is the newest revision.
- \* ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747-2 and IEC 60747-9.

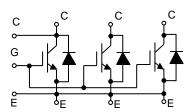
<sup>\*</sup> Please contact our representatives at order.

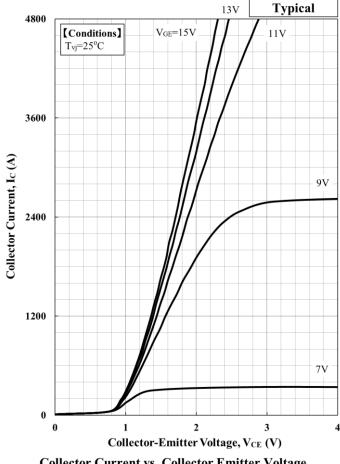
#### **OUTLINE DRAWING**



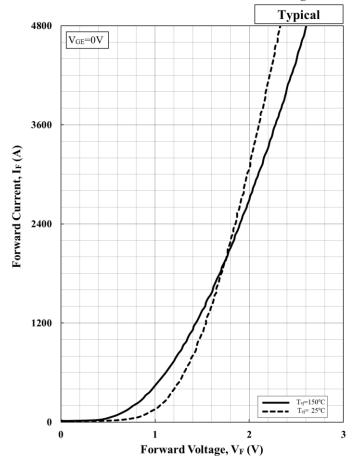


#### **CIRCUIT DIAGRAM**

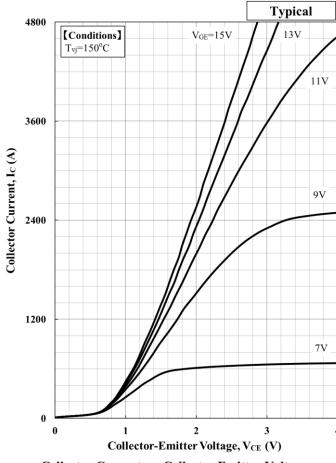




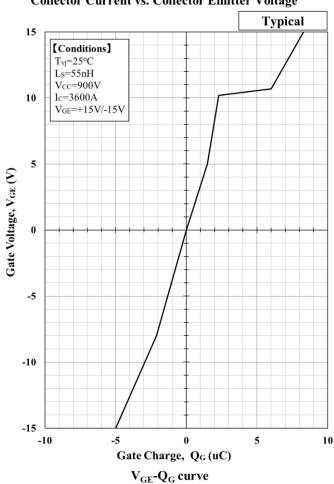


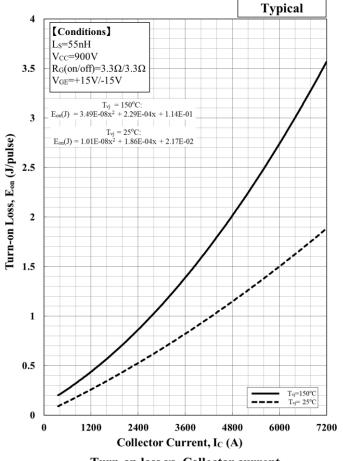


Forward Voltage of free-wheeling diode

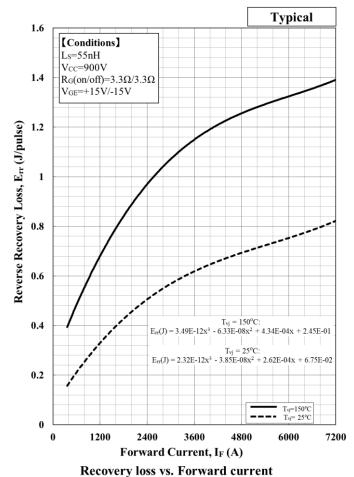


Collector Current vs. Collector Emitter Voltage



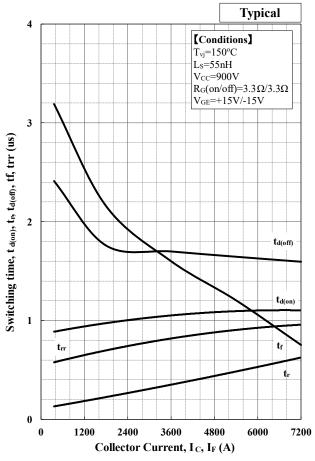


Turn-on loss vs. Collector current

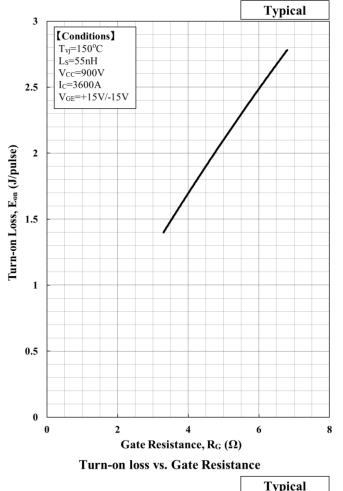


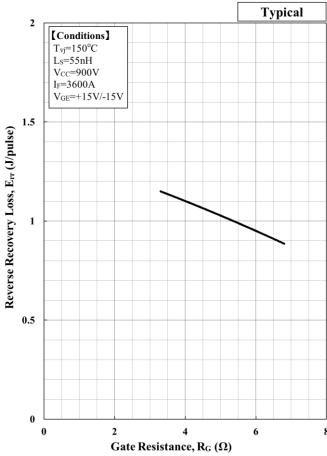
**Typical** [Conditions] L<sub>S</sub>=55nH  $V_{CC} = 900V$  $R_G(on/off)=3.3\Omega/3.3\Omega$ V<sub>GE</sub>=+15V/-15V  $T_{vj} = 150^{\rm o}{\rm C}; \\ E_{\rm off}(J) = 5.14E\text{-}12x^3 - 2.77E\text{-}08x^2 + 7.81E\text{-}04x + 2.71E\text{-}01$ 5 = 25°C:  $E_{\text{off}}(J) = 1.38E-12x^3 + 1.62E-08x^2 + 5.39E-04x + 1.53E-01$ Turn-off Loss, Eoff (J/pulse) 4 3 2 T<sub>vj</sub>=150°C T<sub>vj</sub>= 25°C 1200 2400 3600 4800 6000 7200 Collector Current, Ic (A)

Turn-off loss vs. Collector current



Switching time vs. Collector Current

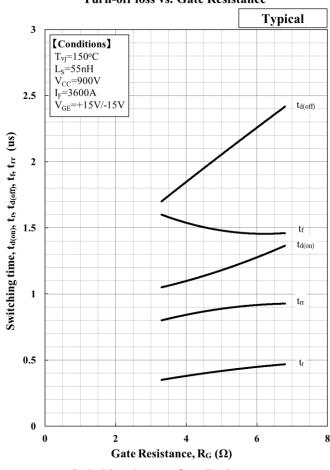




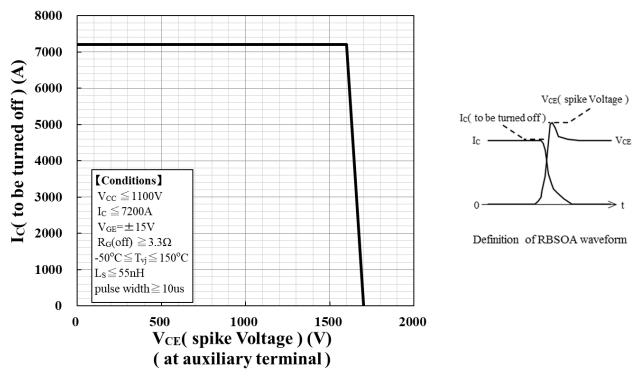
Recovery loss vs. Gate Resistance

**Typical** 5 [Conditions]  $T_{vj}=150^{\circ}C$ L<sub>S</sub>=55nH  $V_{CC}=900V$ Ic=3600A V<sub>GE</sub>=+15V/-15V Turn-off Loss, Eoff (J/pulse) 3 2 0  $\mathbf{0}$ 2 6 Gate Resistance,  $R_G(\Omega)$ 

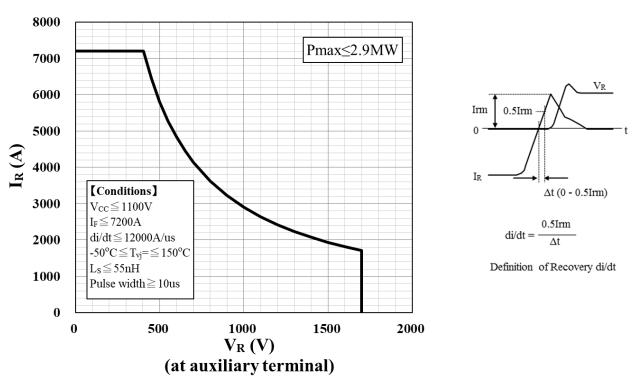
Turn-off loss vs. Gate Resistance



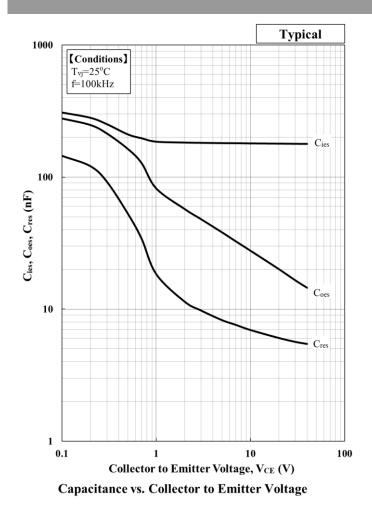
Switching time vs. Gate Resistance

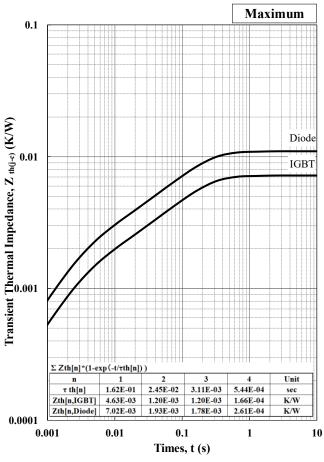


### Reverse Bias Safe Operation Area (RBSOA)



Reverse Recovery Safe Operation Area (RRSOA)





Transient Thermal Impedance Curve

#### **Material declaration**

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

| Material                    | Contained part |
|-----------------------------|----------------|
| Lead (Pb) and its compounds | Solder         |

### Minebea POWER SEMICONDUCTORS

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- 7. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact with Minebea power semiconductor sales department for the latest version of this data sheets
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### Minebea POWER SEMICONDUCTORS

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